

# TVS0500 5V 平缓钳位浪涌保护器件

## 1 特性

- 保护特性符合针对工业信号线路的 2kV、42Ω IEC 61000-4-5 浪涌测试要求
- 43A、8/20μs 浪涌电流下的最大钳位电压为 9.2V
- 关断电压: 5V
- 4mm<sup>2</sup> 小型封装尺寸
- 在 125°C 时, 可耐受超过 5,000 次的 35A 8/20μs 浪涌电流的重复冲击
- 强大的浪涌保护:
  - IEC61000-4-5 (8/20μs): 43A
  - IEC61643-321 (10/1000μs): 22A
- 低泄漏电流
  - 27°C 下为 70pA (典型值)
  - 85°C 下为 6.5nA (典型值)
- 低电容: 155pF
- 集成 4 级 IEC 61000-4-2 ESD 保护

## 2 应用

- 工业传感器
- PLC I/O 模块
- 5V 电源线路
- 电器
- 医疗设备
- 智能仪表

## 3 说明

TVS0500 可将高达 43A 的 IEC 61000-4-5 故障电流进行可靠分流, 以保护系统免受高功率瞬态冲击或雷击。该器件为满足常见的工业信号线路 EMC 要求提供了解决方案, 可通过 42Ω 电阻进行耦合的方式承受最高 2kV IEC 61000-4-5 开路电压。TVS0500 使用独特的反馈机制确保在故障期间发挥精确的平缓钳位能力, 保证系统接触电压低于 10V。精确的电压调节允许设计人员放心地选择具有较低电压容差的系统组件, 不但减少了系统成本和复杂度, 而且不损害可靠性。

此外, TVS0500 还采用 2mm × 2mm 小型 SON 封装, 非常适用于空间受限 应用, 与业内标准的 SMA 和 SMB 封装相比, 尺寸减小了 70%。极低的器件泄露电流和电容确保最大限度地降低了对受保护线路的影响。为了确保在产品的整个寿命期间提供可靠保护, TI 在高温环境下对 TVS0500 进行了 5000 次重复浪涌冲击测试, 但器件性能未发生任何变化。

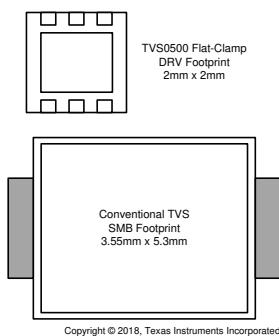
TVS0500 是 TI 的平缓钳位系列浪涌器件中的一款产品。有关该系列其他器件的更多信息, 请参阅 [器件比较表](#)

### 器件信息<sup>(1)</sup>

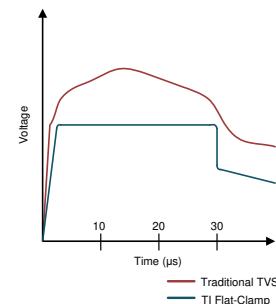
| 器件型号    | 封装      | 封装尺寸 (标称值)      |
|---------|---------|-----------------|
| TVS0500 | SON (6) | 2.00mm × 2.00mm |

(1) 如需了解所有可用封装, 请参阅数据表末尾的可订购产品附录。

### 封装比较



### 对 8/20μs 浪涌事件的电压钳位响应



## 目录

|          |  |          |           |                                       |           |
|----------|--|----------|-----------|---------------------------------------|-----------|
| <b>1</b> | <b>特性</b>                              | <b>1</b> | 8.3       | Feature Description                   | <b>9</b>  |
| <b>2</b> | <b>应用</b>                              | <b>1</b> | 8.4       | Reliability Testing                   | <b>9</b>  |
| <b>3</b> | <b>说明</b>                              | <b>1</b> | 8.5       | Device Functional Modes               | <b>9</b>  |
| <b>4</b> | <b>修订历史记录</b>                          | <b>2</b> | <b>9</b>  | <b>Application and Implementation</b> | <b>11</b> |
| <b>5</b> | <b>Device Comparison Table</b>         | <b>3</b> | 9.1       | Application Information               | <b>11</b> |
| <b>6</b> | <b>Pin Configuration and Functions</b> | <b>4</b> | 9.2       | Typical Application                   | <b>11</b> |
| <b>7</b> | <b>Specifications</b>                  | <b>5</b> | <b>10</b> | <b>Power Supply Recommendations</b>   | <b>12</b> |
| 7.1      | Absolute Maximum Ratings               | 5        | <b>11</b> | <b>Layout</b>                         | <b>13</b> |
| 7.2      | ESD Ratings - JEDEC                    | 5        | 11.1      | Layout Guidelines                     | 13        |
| 7.3      | ESD Ratings - IEC                      | 5        | 11.2      | Layout Example                        | 13        |
| 7.4      | Recommended Operating Conditions       | 5        | <b>12</b> | 器件和文档支持                               | <b>14</b> |
| 7.5      | Thermal Information                    | 5        | 12.1      | 接收文档更新通知                              | 14        |
| 7.6      | Electrical Characteristics             | 6        | 12.2      | 社区资源                                  | 14        |
| 7.7      | Typical Characteristics                | 7        | 12.3      | 商标                                    | 14        |
| <b>8</b> | <b>Detailed Description</b>            | <b>9</b> | 12.4      | 静电放电警告                                | 14        |
| 8.1      | Overview                               | 9        | 12.5      | Glossary                              | 14        |
| 8.2      | Functional Block Diagram               | 9        | <b>13</b> | 机械、封装和可订购信息                           | <b>14</b> |

## 4 修订历史记录

| Changes from Revision B (February 2018) to Revision C           | Page |
|---|------|
| • Fixed grammar error in the <i>Reliability Testing</i> section | 9    |

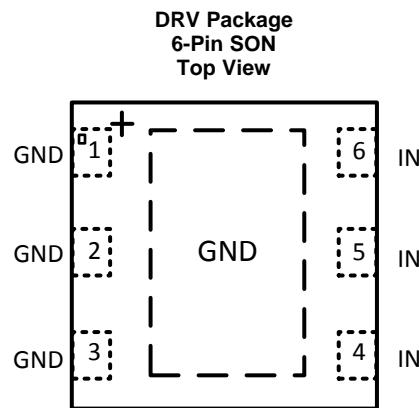
| Changes from Revision A (February 2018) to Revision B  | Page |
|--|------|
| • Changed DC Breakdown Current MAX from 100 to 50 in the Specifications <i>Absolute Maximum Ratings</i> table                          | 5    |
| • Changed Break-down Voltage MIN from 7.6 to 7.5 and MAX from 8.2 to 8.4 in the Specifications <i>Electrical Characteristics</i> table | 5    |

| Changes from Original (December 2017) to Revision A | Page |
|---|------|
|   |      |

## 5 Device Comparison Table

| Device  | $V_{rwm}$ | $V_{clamp}$ at $I_{pp}$ | $I_{pp}$ (8/20 $\mu$ s) | $V_{rwm}$ leakage (nA) | Package Options | Polarity       |
|---------|-----------|-------------------------|-------------------------|------------------------|-----------------|----------------|
| TVS0500 | 5         | 9.2                     | 43                      | 0.07                   | SON             | Unidirectional |
| TVS1400 | 14        | 18.4                    | 43                      | 2                      | SON             | Unidirectional |
| TVS1800 | 18        | 22.8                    | 40                      | 0.5                    | SON             | Unidirectional |
| TVS2200 | 22        | 27.7                    | 40                      | 3.2                    | SON             | Unidirectional |
| TVS2700 | 27        | 32.5                    | 40                      | 1.7                    | SON             | Unidirectional |
| TVS3300 | 33        | 38                      | 35                      | 19                     | WCSP, SON       | Unidirectional |

## 6 Pin Configuration and Functions



### Pin Functions

| PIN  |                              | TYPE | DESCRIPTION                     |
|------|------------------------------|------|---------------------------------|
| NAME | No.                          |      |                                 |
| IN   | 4, 5, 6                      | I    | ESD and surge protected channel |
| GND  | 1, 2, 3, exposed thermal pad | GND  | Ground                          |

## 7 Specifications

### 7.1 Absolute Maximum Ratings

$T_A = 27^\circ\text{C}$  (unless otherwise noted)<sup>(1)</sup>

|                       |  | MIN | MAX | UNIT             |
|-----------------------|--|-----|-----|------------------|
| Maximum Surge         | IEC 61000-4-5 Current (8/20 $\mu\text{s}$ )    |     | 43  | A                |
|                       | IEC 61000-4-5 Power (8/20 $\mu\text{s}$ )      |     | 400 | W                |
|                       | IEC 61643-321 Current (10/1000 $\mu\text{s}$ ) |     | 20  | A                |
|                       | IEC 61643-321 Power (10/1000 $\mu\text{s}$ )   |     | 180 | W                |
| Maximum Forward Surge | IEC 61000-4-5 Current (8/20 $\mu\text{s}$ )    |     | 50  | A                |
|                       | IEC 61000-4-5 Power (8/20 $\mu\text{s}$ )      |     | 80  | W                |
|                       | IEC 61643-321 Current (10/1000 $\mu\text{s}$ ) |     | 23  | A                |
|                       | IEC 61643-321 Power (10/1000 $\mu\text{s}$ )   |     | 60  | W                |
| EFT                   | IEC 61000-4-4 EFT Protection                   |     | 80  | A                |
| $I_{BR}$              | DC Breakdown Current                           |     | 50  | mA               |
| $I_F$                 | DC Forward Current                             |     | 500 | mA               |
| $T_A$                 | Ambient Operating Temperature                  | -40 | 125 | $^\circ\text{C}$ |
| $T_{stg}$             | Storage Temperature                            | -65 | 150 | $^\circ\text{C}$ |

(1) Stresses beyond those listed under *Absolute Maximum Rating* may cause permanent damage to the device. These are stress ratings only, which do not imply functional operation of the device at these or any other conditions beyond those indicated under *Recommended Operating Condition*. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

### 7.2 ESD Ratings - JEDEC

|             |                         | VALUE  | UNIT       |
|-------------|-------------------------|--|------------|
| $V_{(ESD)}$ | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins <sup>(1)</sup>              | $\pm 2000$ |
|             |                         | Charged device model (CDM), per JEDEC specification JESD22-C101, all pins <sup>(2)</sup> |            |

(1) JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process.

### 7.3 ESD Ratings - IEC

|             |                         | VALUE                           | UNIT     |
|-------------|-------------------------|---------------------------------|----------|
| $V_{(ESD)}$ | Electrostatic discharge | IEC 61000-4-2 contact discharge | $\pm 24$ |
|             |                         | IEC 61000-4-2 air-gap discharge |          |

### 7.4 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

|           | PARAMETER                 | MIN | NOM | MAX | UNIT |
|-----------|---------------------------|-----|-----|-----|------|
| $V_{RWM}$ | Reverse Stand-off Voltage |     | 5   |     | V    |

### 7.5 Thermal Information

| THERMAL METRIC <sup>(1)</sup> | TVS0500                                    | UNIT |                           |
|-------------------------------|--|------|---------------------------|
|                               | DRV (SON)                                  |      |                           |
|                               | 6 PINS                                     |      |                           |
| $R_{qJA}$                     | Junction-to-ambient thermal resistance     | 70.4 | $^\circ\text{C}/\text{W}$ |
| $R_{qJC(\text{top})}$         | Junction-to-case (top) thermal resistance  | 73.7 | $^\circ\text{C}/\text{W}$ |
| $R_{qJB}$                     | Junction-to-board thermal resistance       | 40   | $^\circ\text{C}/\text{W}$ |
| $Y_{JT}$                      | Junction-to-top characterization parameter | 2.2  | $^\circ\text{C}/\text{W}$ |

(1) For more information about traditional and new thermal metrics, see the [Semiconductor and IC Package Thermal Metrics](#) application report.

## Thermal Information (continued)

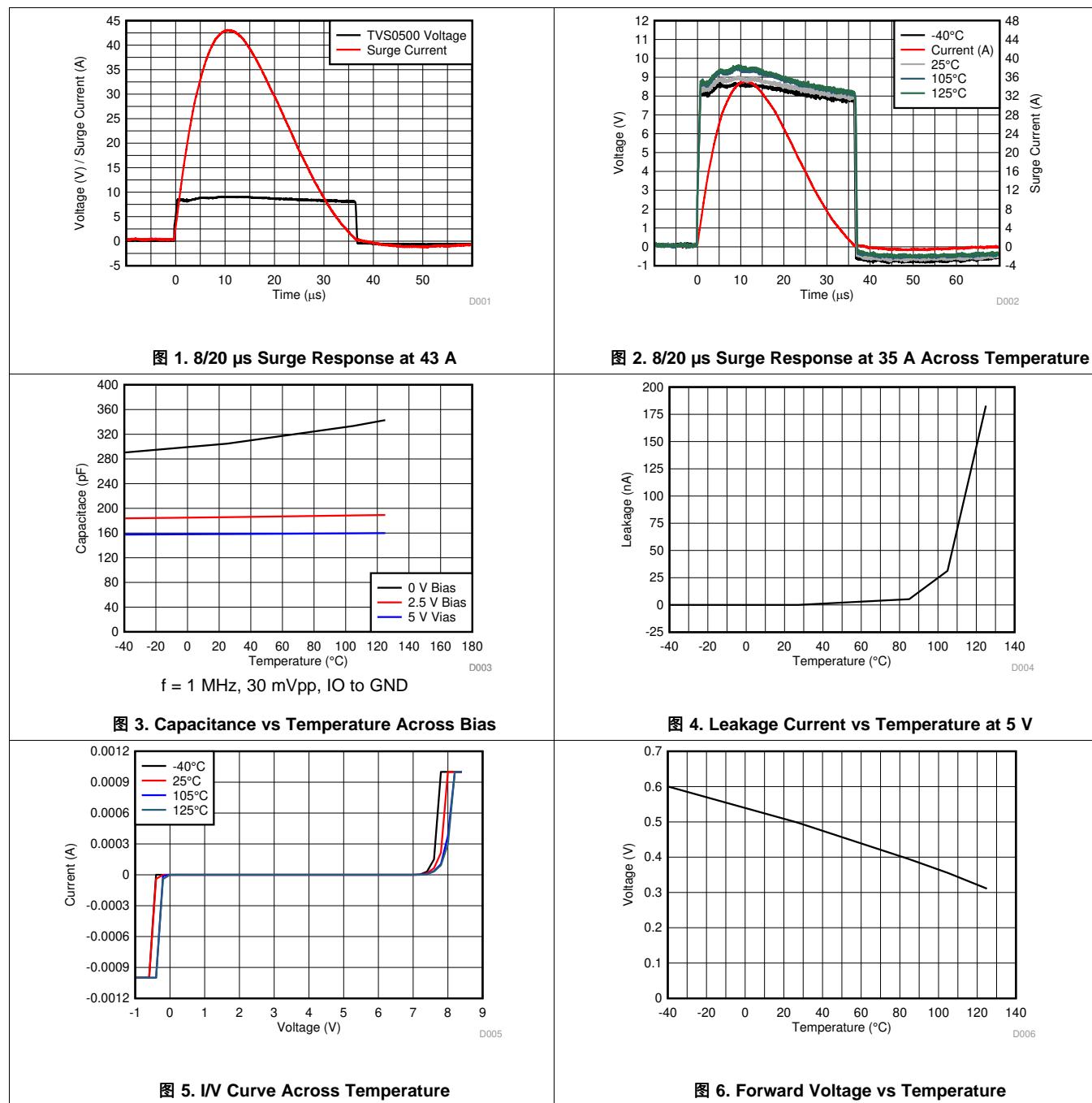
| THERMAL METRIC <sup>(1)</sup> |  | TVS0500   | UNIT |
|-------------------------------|--|-----------|------|
|                               |  | DRV (SON) |      |
|                               |  | 6 PINS    |      |
| Y <sub>JB</sub>               | Junction-to-board characterization parameter | 40.3      | °C/W |
| R <sub>qJC(bot)</sub>         | Junction-to-case (bottom) thermal resistance | 11        | °C/W |

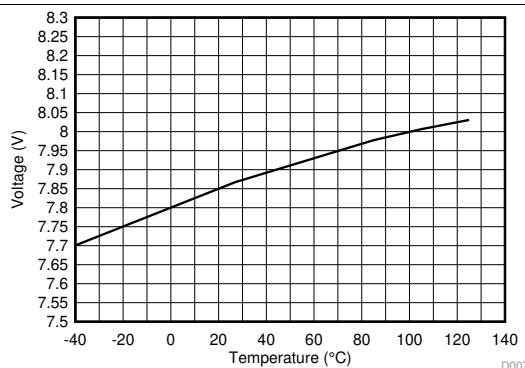
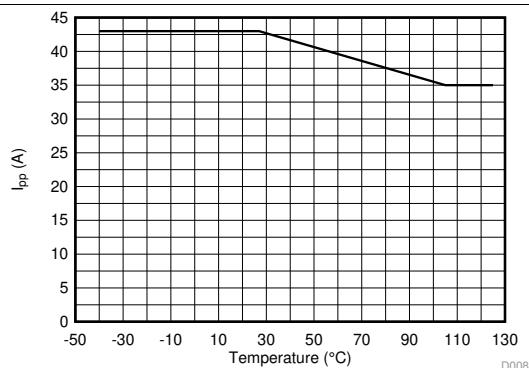
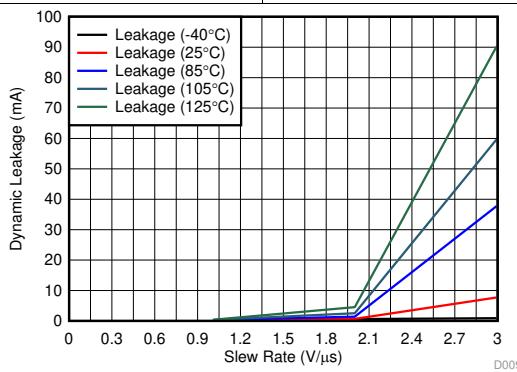
## 7.6 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted)

| PARAMETER   | TEST CONDITIONS  | MIN  | TYP | MAX  | UNIT |
|---|--|------|-----|------|------|
| I <sub>LEAK</sub> Leakage Current                 | Measured at V <sub>IN</sub> = V <sub>RWM</sub> , T <sub>A</sub> = 27°C   | 0.07 | 5.5 | nA   |      |
|   | Measured at V <sub>IN</sub> = V <sub>RWM</sub> , T <sub>A</sub> = 85°C   | 6.5  | 220 | nA   |      |
|   | Measured at V <sub>IN</sub> = V <sub>RWM</sub> , T <sub>A</sub> = 105°C  | 38   | 755 | nA   |      |
| V <sub>F</sub> Forward Voltage                    | I <sub>IN</sub> = 1 mA from GND to IO  | 0.25 | 0.5 | 0.65 | V    |
| V <sub>BR</sub> Break-down Voltage                | I <sub>IN</sub> = 1 mA from IO to GND  | 7.5  | 7.9 | 8.4  | V    |
| V <sub>FCLAMP</sub> Forward Clamp Voltage         | 35 A IEC 61000-4-5 Surge (8/20 µs) from GND to IO, 27°C  | 2    | 5   | 5    | V    |
| V <sub>CLAMP</sub> Clamp Voltage                  | 24 A IEC 61000-4-5 Surge (8/20 µs) from IO to GND, V <sub>IN</sub> = 0 V before surge, 27°C                                | 8.6  | 8.8 | 8.8  | V    |
|   | 43 A IEC 61000-4-5 Surge (8/20 µs) from IO to GND, V <sub>IN</sub> = 0 V before surge, 27°C                                | 9.2  | 9.5 | 9.5  | V    |
|   | 35 A IEC 61000-4-5 Surge (8/20 µs) from IO to GND, V <sub>IN</sub> = V <sub>RWM</sub> before surge, T <sub>A</sub> = 125°C | 9.2  | 9.5 | 9.5  | V    |
| R <sub>DYN</sub> 8/20 µs surge dynamic resistance | Calculated from V <sub>CLAMP</sub> at .5*I <sub>PP</sub> and I <sub>PP</sub> surge current levels, 27°C                    | 30   | 50  | 50   | mΩ   |
| C <sub>IN</sub> Input pin capacitance             | V <sub>IN</sub> = 5 V, f = 1 MHz, 30 mV <sub>PP</sub> , IO to GND  | 155  |     | 155  | pF   |
| SR Maximum Slew Rate                              | 0-V <sub>RWM</sub> rising edge, sweep rise time and measure slew rate when I <sub>PEAK</sub> = 1 mA, 27°C                  | 2.5  |     | 2.5  | V/µs |
|   | 0-V <sub>RWM</sub> rising edge, sweep rise time and measure slew rate when I <sub>PEAK</sub> = 1 mA, 105°C                 | 0.7  |     | 0.7  | V/µs |

## 7.7 Typical Characteristics



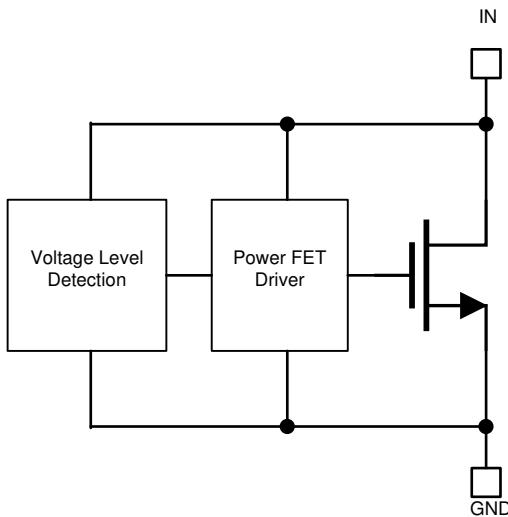
**Typical Characteristics (接下页)**

**图 7. Breakdown Voltage (1 mA) vs Temperature**

**图 8. Max Surge Current (8/20 μs) vs Temperature**

**图 9. Dynamic Leakage vs Signal Slew Rate across Temperature**

## 8 Detailed Description

### 8.1 Overview

The TVS0500 is a precision clamp with a low, flat clamping voltage during transient overvoltage events like surge and protecting the system with zero voltage overshoot.

### 8.2 Functional Block Diagram



### 8.3 Feature Description

The TVS0500 is a precision clamp that handles 43 A of IEC 61000-4-5 8/20  $\mu$ s surge pulse. The flat clamping feature helps keep the clamping voltage very low to keep the downstream circuits from being stressed. The flat clamping feature can also help end-equipment designers save cost by opening up the possibility to use lower-cost, lower voltage tolerant downstream ICs. The TVS0500 has minimal leakage under the standoff voltage of 5 V, making it an ideal candidate for applications where low leakage and power dissipation is a necessity. IEC 61000-4-2 and IEC 61000-4-4 ratings make it a robust protection solution for ESD and EFT events. Wide ambient temperature range of  $-40^{\circ}\text{C}$  to  $+125^{\circ}\text{C}$  a good candidate for most applications. Compact packages enable it to be used in small devices and save board area.

### 8.4 Reliability Testing

To ensure device reliability, the TVS0500 is characterized against 5000 repetitive pulses of 35 A IEC 61000-4-5 8/20  $\mu$ s surge pulses at  $125^{\circ}\text{C}$ . The test is performed with less than 10 seconds between each pulse at high temperature to simulate worst case scenarios for fault regulation. After each surge pulse, the TVS0500 clamping voltage, breakdown voltage, and leakage are recorded to ensure that there is no variation or performance degradation. By ensuring robust, reliable, high temperature protection, the TVS0500 enables fault protection in applications that must withstand years of continuous operation with no performance change.

### 8.5 Device Functional Modes

#### 8.5.1 Protection Specifications

The TVS0500 is specified according to both the IEC 61000-4-5 and IEC 61643-321 standards. This enables usage in systems regardless of which standard is required in relevant product standards or best matches measured fault conditions. The IEC 61000-4-5 standards requires protection against a pulse with a rise time of 8  $\mu$ s and a half length of 20  $\mu$ s, while the IEC 61643-321 standard requires protection against a much longer pulse with a rise time of 10  $\mu$ s and a half length of 1000  $\mu$ s.

## Device Functional Modes (接下页)

The positive and negative surges are imposed to the TVS0500 by a combinational waveform generator (CWG) with a  $2\Omega$  coupling resistor at different peak voltage levels. For powered on transient tests that need power supply bias, inductances are usually used to decouple the transient stress and protect the power supply. The TVS0500 is post tested by assuring that there is no shift in device breakdown or leakage at  $V_{rwm}$ .

In addition, the TVS0500 has been tested according to IEC 61000-4-5 to pass a  $\pm 2$  kV surge test through a  $42\Omega$  coupling resistor and a  $0.5\mu F$  capacitor. This test is a common test requirement for industrial signal I/O lines and the TVS0500 will serve an ideal protection solution for applications with that requirement.

The TVS0500 allows integrates IEC 61000-4-2 level 4 ESD Protection and 80 A of IEC 61000-4-4 EFT Protection. These combine to ensure that the device can protect against most transient conditions regardless of length or type.

For more information on TI's test methods for Surge, ESD, and EFT testing, reference [TI's IEC 61000-4-x Testing Application Note](#)

### 8.5.2 Minimal Derating

Unlike traditional diodes the TVS0500 has very little derating of max power dissipation and ensures robust performance up to  $125^\circ C$ , shown in [图 8](#). Traditional TVS diodes lose up to 50% of their current carrying capability when at high temperatures, so a surge pulse above  $85^\circ C$  ambient can cause failures that are not seen at room temperature. The TVS0500 prevents this and ensures that you will see the same level of protection regardless of temperature.

### 8.5.3 Transient Performance

During large transient swings, the TVS0500 will begin clamping the input signal to protect downstream conditions. While this prevents damage during fault conditions, it can cause leakage when the intended input signal has a fast slew rate. In order to keep power dissipation low and remove the chance of signal distortion, it is recommended to keep the slew rate of any input signal on the TVS0500 below  $2.5\text{ V}/\mu\text{s}$  at room temperature and below  $0.7\text{ V}/\mu\text{s}$  at  $125^\circ C$  shown in [图 9](#). Faster slew rates will cause the device to clamp the input signal and draw current through the device for a few microseconds, increasing the rise time of the signal. This will not cause any harm to the system or to the device, however if the fast input voltage swings occur regularly it can cause device overheating.

## 9 Application and Implementation

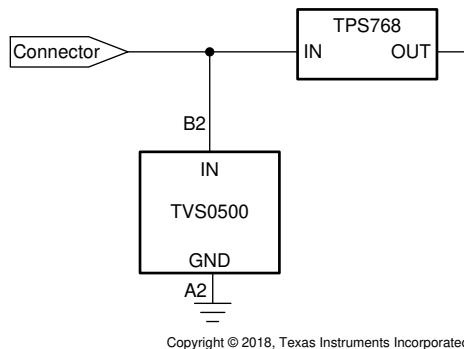
### 注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes. Customers should validate and test their design implementation to confirm system functionality.

### 9.1 Application Information

The TVS0500 can be used to protect any power, analog, or digital signal from transient fault conditions caused by the environment or other electrical components.

### 9.2 Typical Application



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图 10. TVS0500 Application Schematic

#### 9.2.1 Design Requirements

A typical operation for the TVS0500 would be protecting a nominal 5 V input to an LDO similar to [图 10](#). In this example, the TVS0500 is protecting the input to a TPS768, a standard 1 A LDO with an input voltage range of 2.7 V to 10 V. Without any input protection, if a surge event is caused by lightning, coupling, ringing, or any other fault condition this input voltage will rise to hundreds of volts for multiple microseconds, violating the absolute maximum input voltage and harming the device. An ideal surge protection diode will maximize the useable voltage range while still clamping at a safe level for the system, TI's Flat-Clamp technology provides the best protection solution.

#### 9.2.2 Detailed Design Procedure

If the TVS0500 is in place to protect the device, during a surge event the voltage will rise to the breakdown of the diode at 7.9 V, and then the TVS0500 will turn on, shunting the surge current to ground. With the low dynamic resistance of the TVS0500, large amounts of surge current will have minimal impact on the clamping voltage. The dynamic resistance of the TVS0500 is around 30 mΩ, which means 30 A of surge current will cause a voltage raise of  $30 \text{ A} \times 30 \text{ m}\Omega = 0.9 \text{ V}$ . Because the device turns on at 7.9 V, this means the LDO input will be exposed to a maximum of  $7.9 \text{ V} + 0.9 \text{ V} = 8.8 \text{ V}$  during surge pulses, well within the absolute maximum input voltage. This ensures robust protection of your circuit.

The small size of the device also improves fault protection by lowering the effect of fault current coupling onto neighboring traces. The small form factor of the TVS0500 allows the device to be placed extremely close to the input connector, lowering the length of the path fault current will take through the system compared to larger protection solutions.

Finally, the low leakage of the TVS0500 will have low input power losses. At 5 V, the device will see typical 70 pA leakage for a constant power dissipation of less than 1 nW, a negligible quantity that will not effect overall efficiency metrics or add heating concerns.

## Typical Application (接下页)

### 9.2.3 Configuration Options

The TVS0500 can be used in either unidirectional or bidirectional configuration. [图 10](#) shows unidirectional usage to protect an input. By placing two TVS0500's in series with reverse orientation, bidirectional operation can be used, allowing a working voltage of  $\pm 5$  V. TVS0500 operation in bidirectional will be similar to unidirectional operation, with a minor increase in breakdown voltage and clamping voltage. The TVS3300 bidirectional performance has been characterized in the [TVS3300 Configurations Characterization](#). While the TVS0500 in bidirectional configuration has not specifically been characterized, it will have similar relative changes to the TVS3300 in bidirectional configuration.

## 10 Power Supply Recommendations

The TVS0500 is a clamping device so there is no need to power it. To ensure the device functions properly do not violate the recommended  $V_{IN}$  voltage range (0 V to 5 V).

## 11 Layout

### 11.1 Layout Guidelines

The optimum placement is close to the connector. EMI during an ESD event can couple from the trace being struck to other nearby unprotected traces, resulting in early system failures. The PCB designer must minimize the possibility of EMI coupling by keeping any unprotected traces away from the protected traces which are between the TVS and the connector.

Route the protected traces straight.

Eliminate any sharp corners on the protected traces between the TVS0500 and the connector by using rounded corners with the largest radii possible. Electric fields tend to build up on corners, increasing EMI coupling.

### 11.2 Layout Example

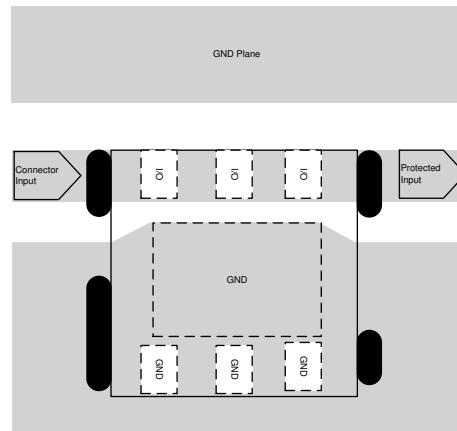


图 11. TVS0500 Layout

## 12 器件和文档支持

### 12.1 接收文档更新通知

要接收文档更新通知, 请导航至 [ti.com](http://ti.com) 上的器件产品文件夹。单击右上角的通知我进行注册, 即可每周接收产品信息更改摘要。有关更改的详细信息, 请查看任何已修订文档中包含的修订历史记录。

### 12.2 社区资源

[TI E2E™ support forums](#) are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

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### 12.3 商标

E2E is a trademark of Texas Instruments.

### 12.4 静电放电警告

 ESD 可能会损坏该集成电路。德州仪器 (TI) 建议通过适当的预防措施处理所有集成电路。如果不遵守正确的处理措施和安装程序, 可能会损坏集成电路。

 ESD 的损坏小至导致微小的性能降级, 大至整个器件故障。精密的集成电路可能更容易受到损坏, 这是因为非常细微的参数更改都可能会导致器件与其发布的规格不相符。

### 12.5 Glossary

[SLYZ022 — TI Glossary](#).

This glossary lists and explains terms, acronyms, and definitions.

## 13 机械、封装和可订购信息

以下页面包含机械、封装和可订购信息。这些信息是指定器件的最新可用数据。数据如有变更, 恕不另行通知, 且不会对此文档进行修订。如需获取此数据表的浏览器版本, 请查阅左侧的导航栏。

**PACKAGING INFORMATION**

| Orderable part number | Status<br>(1) | Material type<br>(2) | Package   Pins | Package qty   Carrier | RoHS<br>(3) | Lead finish/<br>Ball material<br>(4) | MSL rating/<br>Peak reflow<br>(5) | Op temp (°C) | Part marking<br>(6) |
|-----------------------|---------------|----------------------|----------------|-----------------------|-------------|--------------------------------------|-----------------------------------|--------------|---------------------|
| TVS0500DRV            | Active        | Production           | WSON (DRV)   6 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | 1HRH                |
| TVS0500DRV.R.A        | Active        | Production           | WSON (DRV)   6 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | 1HRH                |
| TVS0500DRVRG4         | Active        | Production           | WSON (DRV)   6 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | 1HRH                |
| TVS0500DRVRG4.A       | Active        | Production           | WSON (DRV)   6 | 3000   LARGE T&R      | Yes         | NIPDAU                               | Level-1-260C-UNLIM                | -40 to 125   | 1HRH                |

<sup>(1)</sup> **Status:** For more details on status, see our [product life cycle](#).

<sup>(2)</sup> **Material type:** When designated, preproduction parts are prototypes/experimental devices, and are not yet approved or released for full production. Testing and final process, including without limitation quality assurance, reliability performance testing, and/or process qualification, may not yet be complete, and this item is subject to further changes or possible discontinuation. If available for ordering, purchases will be subject to an additional waiver at checkout, and are intended for early internal evaluation purposes only. These items are sold without warranties of any kind.

<sup>(3)</sup> **RoHS values:** Yes, No, RoHS Exempt. See the [TI RoHS Statement](#) for additional information and value definition.

<sup>(4)</sup> **Lead finish/Ball material:** Parts may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

<sup>(5)</sup> **MSL rating/Peak reflow:** The moisture sensitivity level ratings and peak solder (reflow) temperatures. In the event that a part has multiple moisture sensitivity ratings, only the lowest level per JEDEC standards is shown. Refer to the shipping label for the actual reflow temperature that will be used to mount the part to the printed circuit board.

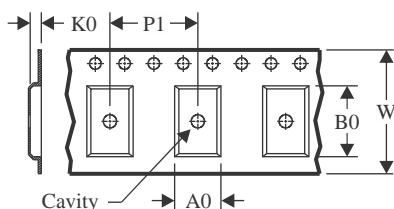
<sup>(6)</sup> **Part marking:** There may be an additional marking, which relates to the logo, the lot trace code information, or the environmental category of the part.

Multiple part markings will be inside parentheses. Only one part marking contained in parentheses and separated by a "~" will appear on a part. If a line is indented then it is a continuation of the previous line and the two combined represent the entire part marking for that device.

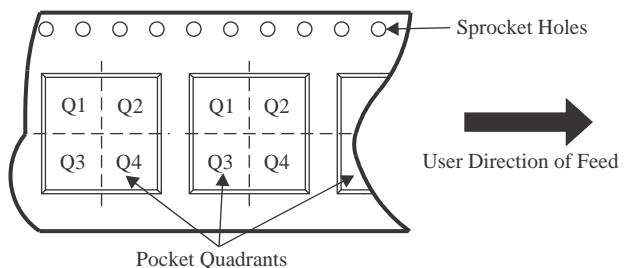
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**TAPE AND REEL INFORMATION**
**REEL DIMENSIONS**

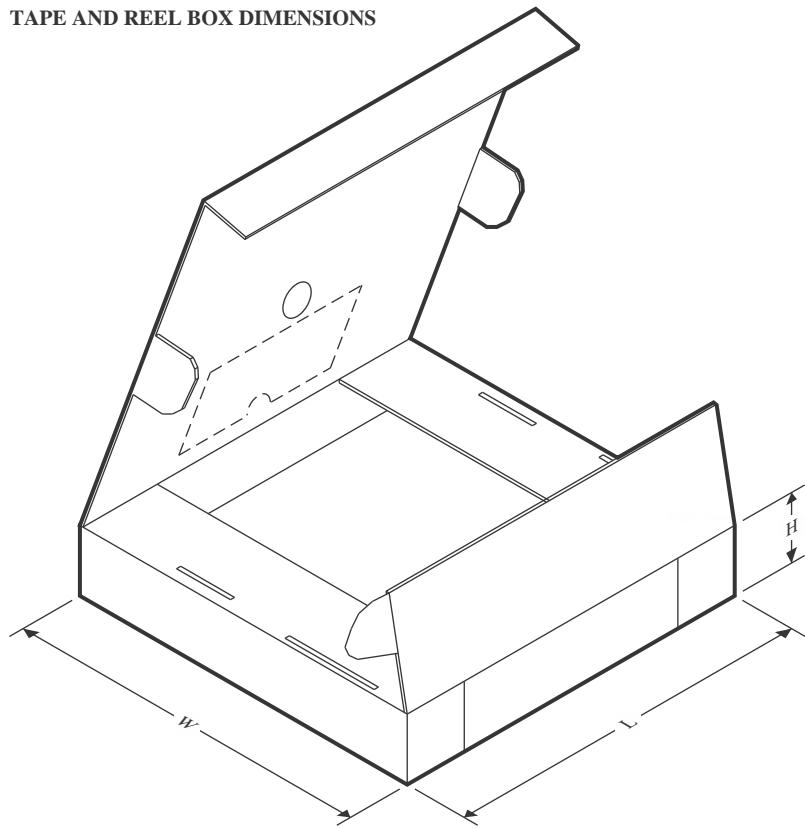
**TAPE DIMENSIONS**


|    |   |
|----|---|
| A0 | Dimension designed to accommodate the component width     |
| B0 | Dimension designed to accommodate the component length    |
| K0 | Dimension designed to accommodate the component thickness |
| W  | Overall width of the carrier tape                         |
| P1 | Pitch between successive cavity centers                   |

**QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE**


\*All dimensions are nominal

| Device        | Package Type | Package Drawing | Pins | SPQ  | Reel Diameter (mm) | Reel Width W1 (mm) | A0 (mm) | B0 (mm) | K0 (mm) | P1 (mm) | W (mm) | Pin1 Quadrant |
|---------------|--------------|-----------------|------|------|--------------------|--------------------|---------|---------|---------|---------|--------|---------------|
| TVS0500DRV    | WSON         | DRV             | 6    | 3000 | 180.0              | 8.4                | 2.3     | 2.3     | 1.15    | 4.0     | 8.0    | Q2            |
| TVS0500DRVRG4 | WSON         | DRV             | 6    | 3000 | 180.0              | 8.4                | 2.3     | 2.3     | 1.15    | 4.0     | 8.0    | Q2            |

**TAPE AND REEL BOX DIMENSIONS**


\*All dimensions are nominal

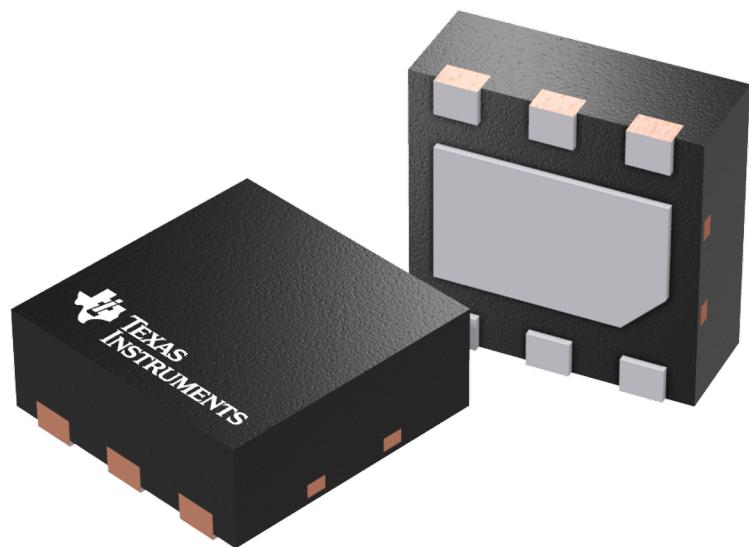
| Device         | Package Type | Package Drawing | Pins | SPQ  | Length (mm) | Width (mm) | Height (mm) |
|----------------|--------------|-----------------|------|------|-------------|------------|-------------|
| TVS0500DRVVR   | WSON         | DRV             | 6    | 3000 | 210.0       | 185.0      | 35.0        |
| TVS0500DRVVRG4 | WSON         | DRV             | 6    | 3000 | 210.0       | 185.0      | 35.0        |

**DRV 6**

**GENERIC PACKAGE VIEW**

**WSON - 0.8 mm max height**

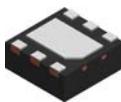
PLASTIC SMALL OUTLINE - NO LEAD



Images above are just a representation of the package family, actual package may vary.  
Refer to the product data sheet for package details.

4206925/F

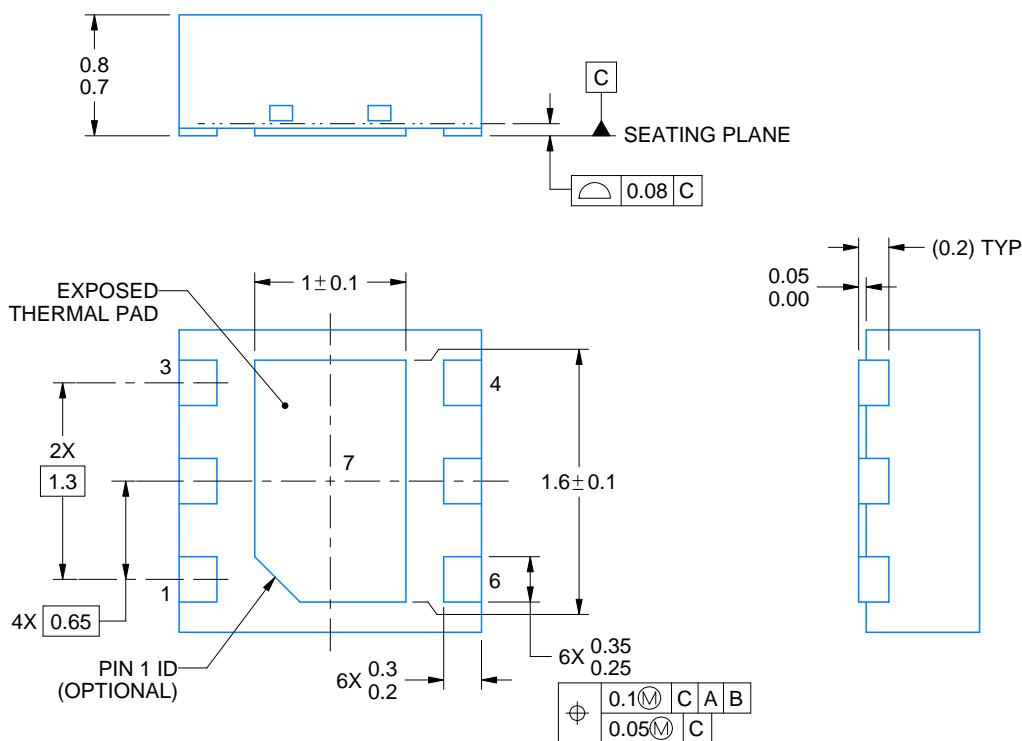
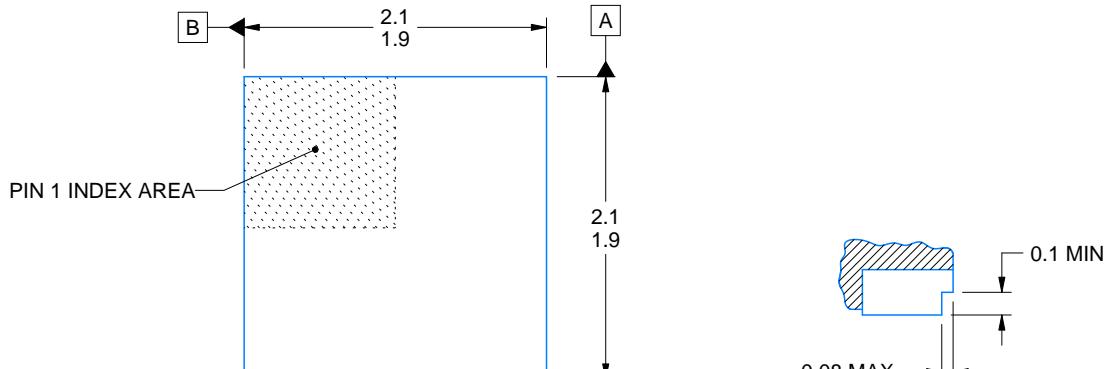
DRV0006A



# PACKAGE OUTLINE

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



4222173/C 11/2025

## NOTES:

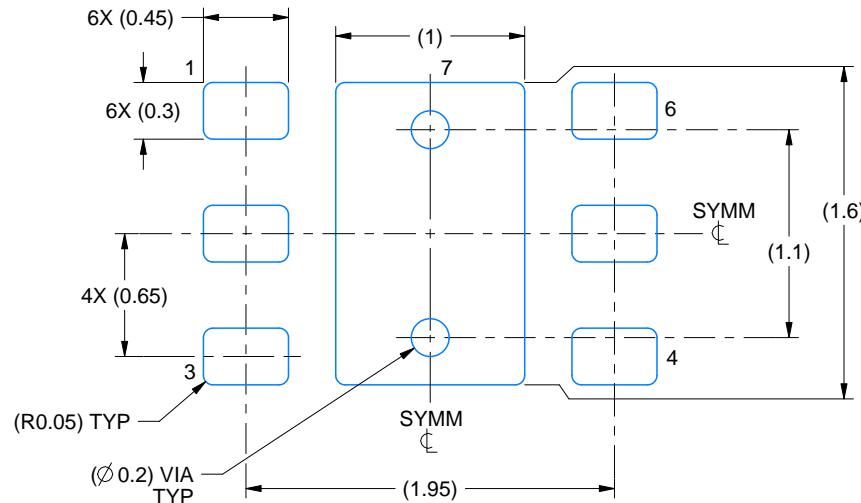
1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing per ASME Y14.5M.
2. This drawing is subject to change without notice.
3. The package thermal pad must be soldered to the printed circuit board for thermal and mechanical performance.
4. Minimum 0.1 mm solder wetting on pin side wall. Available for wettable flank version only.

# EXAMPLE BOARD LAYOUT

DRV0006A

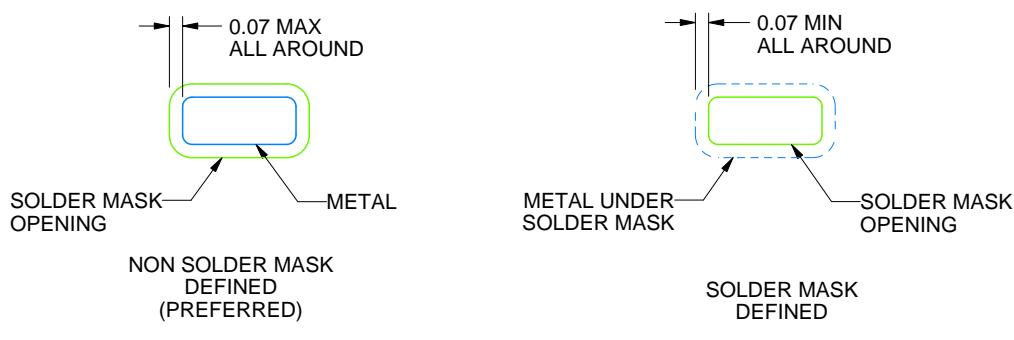
WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



LAND PATTERN EXAMPLE

SCALE:25X



SOLDER MASK DETAILS

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NOTES: (continued)

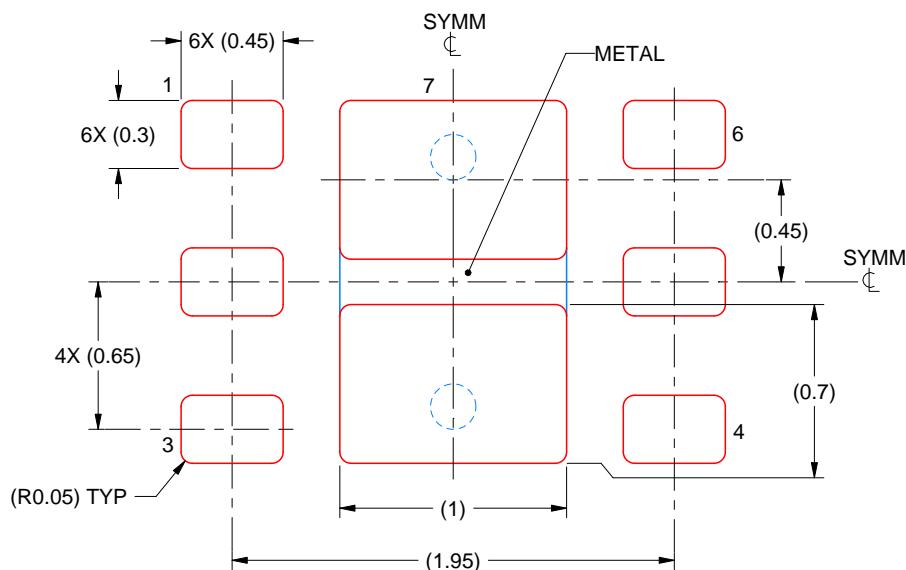
5. This package is designed to be soldered to a thermal pad on the board. For more information, see Texas Instruments literature number SLUA271 ([www.ti.com/lit/slua271](http://www.ti.com/lit/slua271)).
6. Vias are optional depending on application, refer to device data sheet. If some or all are implemented, recommended via locations are shown.

# EXAMPLE STENCIL DESIGN

DRV0006A

WSON - 0.8 mm max height

PLASTIC SMALL OUTLINE - NO LEAD



SOLDER PASTE EXAMPLE  
BASED ON 0.125 mm THICK STENCIL

EXPOSED PAD #7  
88% PRINTED SOLDER COVERAGE BY AREA UNDER PACKAGE  
SCALE:30X

4222173/C 11/2025

NOTES: (continued)

7. Laser cutting apertures with trapezoidal walls and rounded corners may offer better paste release. IPC-7525 may have alternate design recommendations.

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